

March 2001

FQB13N50 / FQI13N50

500V N-Channel MOSFET

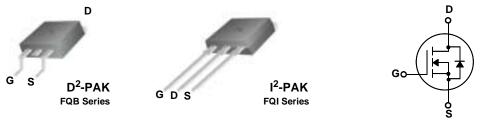
General Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply, power factor correction, and electronic lamp ballast based on half bridge.

Features

- 12.5A, 500V. $R_{DS(on)} = 0.43\Omega$ @V_{GS} = 10 V Low gate charge (typical 45 nC).
- Low Crss (typical 25 pF).
- · Fast switching.
- 100% avalanche tested.
- · Improved dv/dt capability.



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQB13N50 / FQI13N50	Units
V _{DSS}	Drain-Source Voltage		500	V
I _D	Drain Current - Continuous (T _C = 25°	°C)	12.5	Α
	- Continuous (T _C = 100°C)		7.9	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	50	Α
V_{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	810	mJ
I _{AR}	Avalanche Current	(Note 1)	12.5	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	17	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P _D	Power Dissipation ($T_A = 25^{\circ}C$) * Power Dissipation ($T_C = 25^{\circ}C$)		3.13	W
			170	W
	- Derate above 25°C	•	1.35	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.74	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	i	Min	Тур	Max	Units
Off Cha	aracteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced	to 25°C		0.48		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 500 V, V _{GS} = 0 V				1	μΑ
		V _{DS} = 400 V, T _C = 125°C	;			10	μА
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Cha	aracteristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 6.25 A			0.33	0.43	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_D = 6.25 \text{ A}$	(Note 4)		10		S
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			1800 245	2300 320	pF pF
C _{rss}	Reverse Transfer Capacitance				25	35	pF
.00	·						•
Switchi	ing Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 13.4 A,			40	90	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$,		140	290	ns
t _{d(off)}	Turn-Off Delay Time				100	210	ns
t _f	Turn-Off Fall Time		(Note 4, 5)		85	180	ns
Qg	Total Gate Charge	V _{DS} = 400 V, I _D = 13.4 A	,		45	60	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V (Note			11		nC
Q _{gd}	Gate-Drain Charge				22		nC
	Source Diode Characteristics ar		S			l	
I _S	Maximum Continuous Drain-Source Diode Forward Current					12.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F					50	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 12.5 A				1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_S = 13.4 \text{ A},$	(Note 4)		290		ns
Q_{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$	(Note 4)		2.6		μC

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 9.3mH, I_{AS} = 12.5A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C 3. I_{SD} \leq 13.4A, di/dt \leq 2004/ μ s, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C 4. Pulse Test : Pulse width \leq 300 μ s, Duty cycle \leq 2% 5. Essentially independent of operating temperature

Typical Characteristics

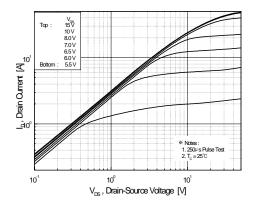


Figure 1. On-Region Characteristics

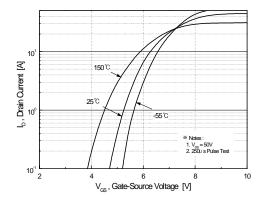


Figure 2. Transfer Characteristics

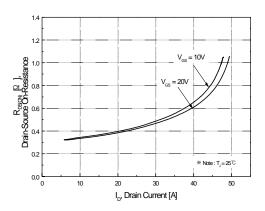


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

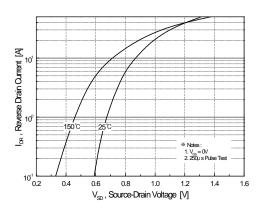


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

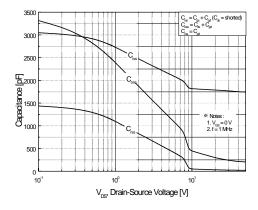


Figure 5. Capacitance Characteristics

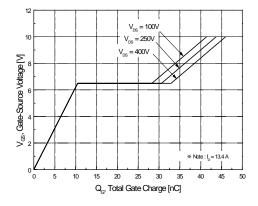
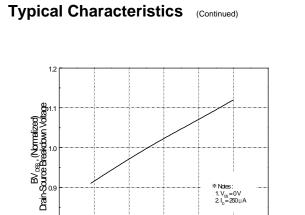


Figure 6. Gate Charge Characteristics

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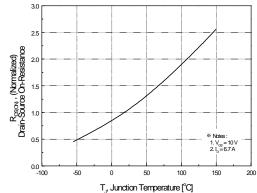


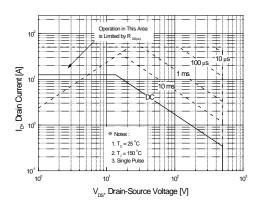
Figure 7. Breakdown Voltage Variation vs. Temperature

T_J, Junction Temperature [°C]

150

0.8 L -100

Figure 8. On-Resistance Variation vs. Temperature



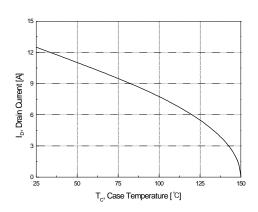


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

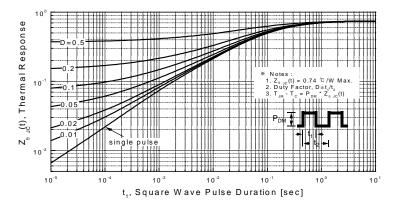
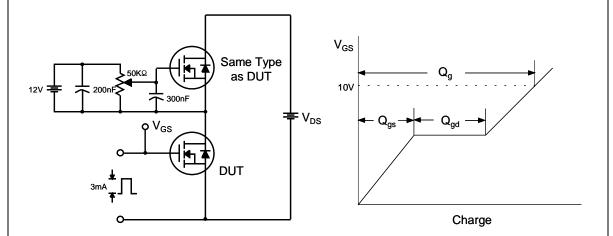


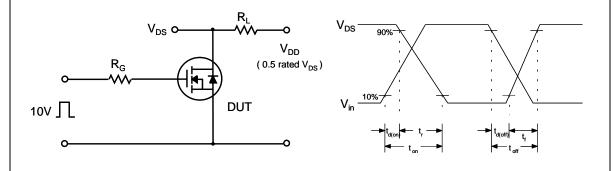
Figure 11. Transient Thermal Response Curve

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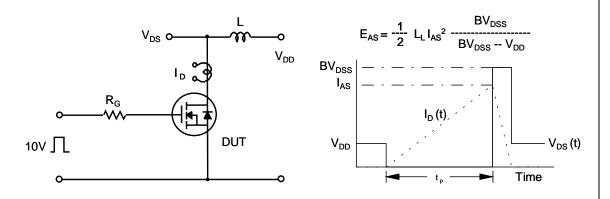
Gate Charge Test Circuit & Waveform



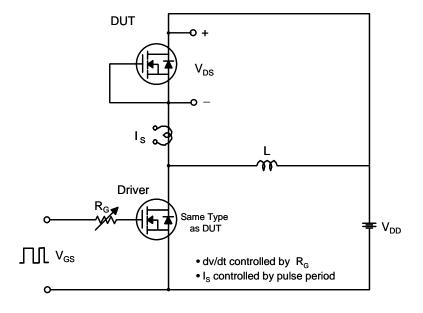
Resistive Switching Test Circuit & Waveforms

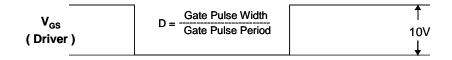


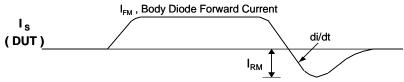
Unclamped Inductive Switching Test Circuit & Waveforms



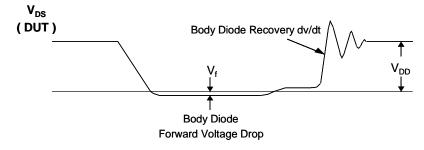
Peak Diode Recovery dv/dt Test Circuit & Waveforms

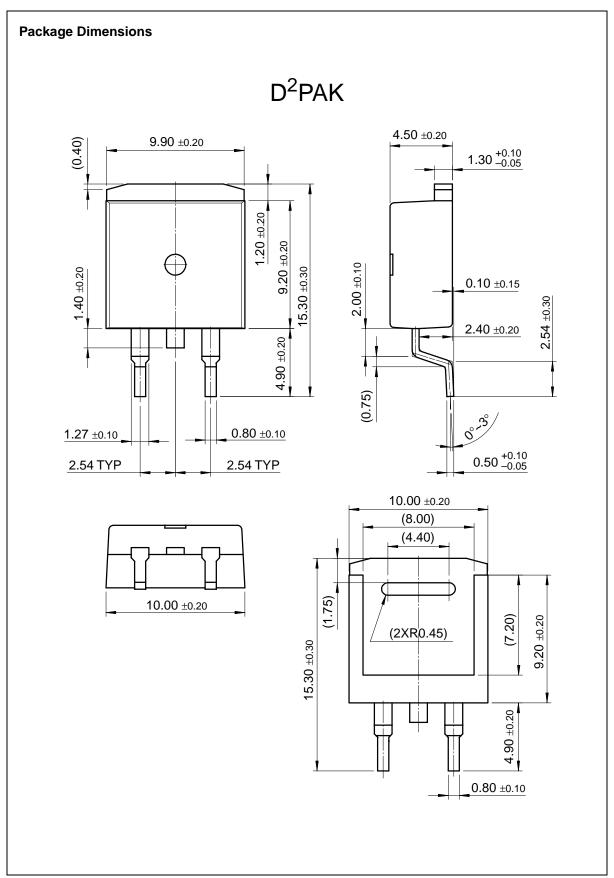


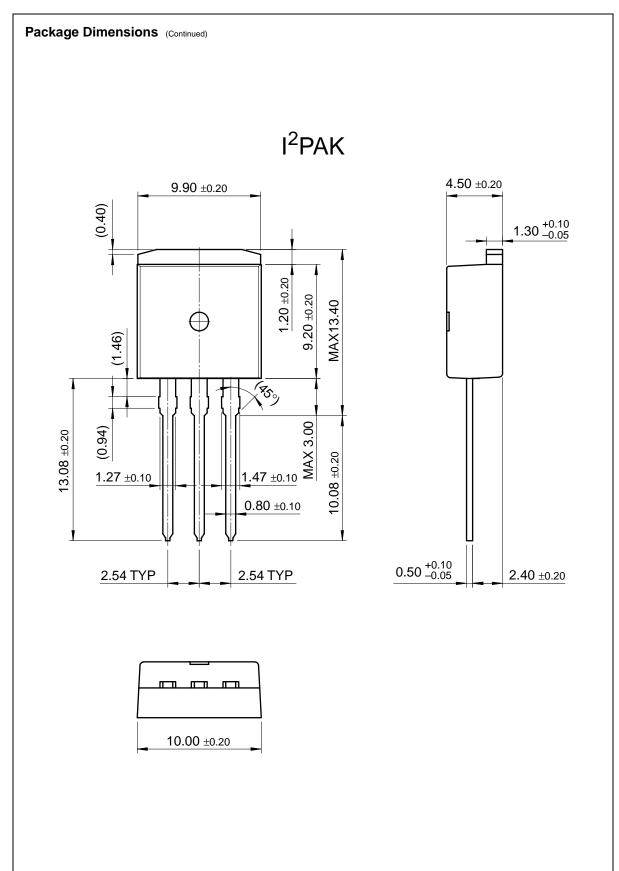




Body Diode Reverse Current







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